

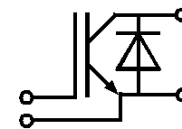
Absolute Maximum Ratings		Values		Units
Symbol	Conditions ¹⁾			
V _{CES}		1700		V
V _{CGR}	R _{GE} = 20 kΩ	1700		V
I _C	T _{case} = 25/80 °C	440 / 300		A
I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	880 / 600		A
V _{GES}		± 20		V
P _{tot}	per IGBT, T _{case} = 25 °C	2500		W
T _j , (T _{stg})		- 40 ... +150 (125)		°C
V _{isol}	AC, 1 min.	4000		V
humidity	DIN 40 040	Class F		
climate	DIN IEC 68 T.1	40/125/56		
Inverse Diode ⁸⁾			D1 S	
I _F = - I _C	T _{case} = 25/80 °C	300 / 200	400 / 270	A
I _{FM} = - I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	880 / 600	880 / 600	A
I _{FSM}	t _p = 10 ms; sin.; T _j = 150 °C	2900	4400	A
I ² t	t _p = 10 ms; T _j = 150 °C	42000	96000	A ² s

SEMITRANS® M
IGBT Modules
SKM 400 GA 173 D
SKM 400 GA 173 D1 S



SEMITRANS 4

Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
V _{(BR)CES}	V _{GE} = 0, I _C = 5,6 mA	≥ V _{CES}	-	-	V
V _{GE(th)}	V _{GE} = V _{CE} , I _C = 20 mA	4,8	5,5	6,2	V
I _{CES}	V _{GE} = 0 } T _j = 25 °C V _{CE} = V _{CES} } T _j = 125 °C	-	-	2	mA
		-	-	4,5	mA
I _{GES}	V _{GE} = 20 V, V _{CE} = 0 V	-	-	400	nA
V _{CEsat}	I _C = 300 A } V _{GE} = 15 V; I _C = 400 A } T _j = 25 (125) °C	-	3,0(4,3)	3,9(5)	V
g _{fs}	V _{CE} = 20 V, I _C = 300 A	108	-	-	S
C _{CHC}	per IGBT	-	-	400	pF
C _{ies}	} V _{GE} = 0 } V _{CE} = 25 V } f = 1 MHz	-	44	-	nF
C _{oes}		-	3,5	-	nF
C _{res}		-	1	-	nF
L _{CE}		-	-	-	20
t _{d(on)}	} V _{CC} = 1200 V } V _{GE} = + 15 V / - 15 V ³⁾ } I _C = 300 A, ind. load } R _{Gon} = R _{Goff} = 2 Ω } T _j = 125 °C	-	550	-	ns
t _r		-	120	-	ns
t _{d(off)}		-	850	-	ns
t _f		-	50	-	ns
E _{on}		-	180	-	mWs
E _{off}		-	10	-	mWs
Inverse Diode ⁸⁾					
V _F = V _{EC}	I _F = 300 A } V _{GE} = 0 V; I _F = 400 A } T _j = 25 (125) °C	-	2,2(1,9)	2,7(2,4)	V
V _F = V _{EC}		-	2,46(2,25)	-	V
V _{TO}	T _j = 125 °C	-	1,3	1,5	V
r _T	T _j = 125 °C	-	2,9	3,2	mΩ
I _{RR}	I _F = 300 A; T _j = 25 (125) °C ²⁾	-	120(170)	-	A
Q _{rr}	I _F = 300 A; T _j = 25 (125) °C ²⁾	-	30(72)	-	μC
Diodes of "D1" ⁸⁾					
V _F = V _{EC}	I _F = 300 A } V _{GE} = 0 V; I _F = 400 A } T _j = 25 (125) °C	-	2,1(1,8)	2,4	V
V _F = V _{EC}		-	-	2,2(2,1)	2,7
V _{TO}	T _j = 125 °C	-	1,3	1,5	V
r _T	T _j = 125 °C	-	2	2,5	mΩ
I _{RR}	I _F = 300 A; T _j = 25 (125) °C ²⁾	-	120(180)	-	A
Q _{rr}	I _F = 300 A; T _j = 25 (125) °C ²⁾	-	60(85)	-	μC
Thermal Characteristics					
R _{thjc}	per IGBT	-	-	0,05	°C/W
R _{thjc}	per diode D / "D1 S"	-	-	0,17/0,12	°C/W
R _{thch}	per module	-	-	0,038	°C/W



GA

Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 * I_{cnom}
- Latch-up free
- Fast & soft inverse CAL diodes⁸⁾
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (13 mm) and creepage distances (20 mm).

Typical Applications:

- AC inverter drives on mains 575 - 750 V_{AC}
- DC bus voltage 750 - 1200 V_{DC}
- Public transport
- Switching (not for linear use)

¹⁾ T_{case} = 25 °C, unless otherwise specified

²⁾ I_F = - I_C, V_R = 1200 V, - di_F/dt = 1500 A/μs, V_{GE} = 0 V

³⁾ Use V_{GEoff} = -5 ... -15 V

⁸⁾ CAL = Controlled Axial Lifetime Technology.

Cases and mech. data → B6-276 "D1S" → B6-212

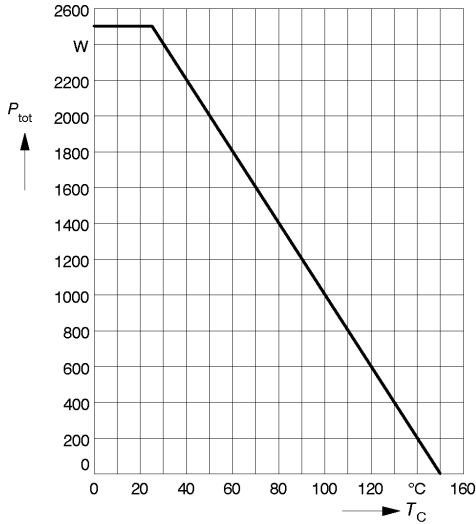


Fig. 1 Rated power dissipation $P_{tot} = f(T_C)$

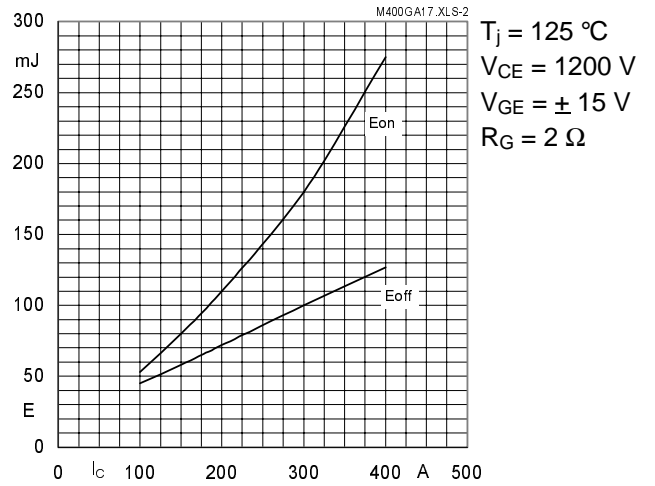


Fig. 2 Turn-on /off energy = $f(I_C)$

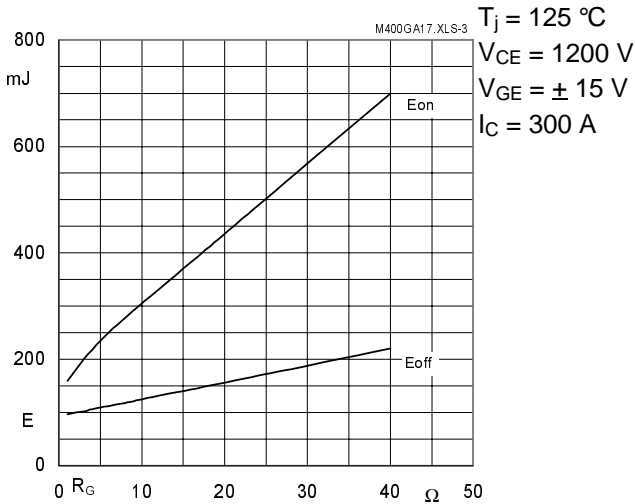


Fig. 3 Turn-on /off energy = $f(R_G)$

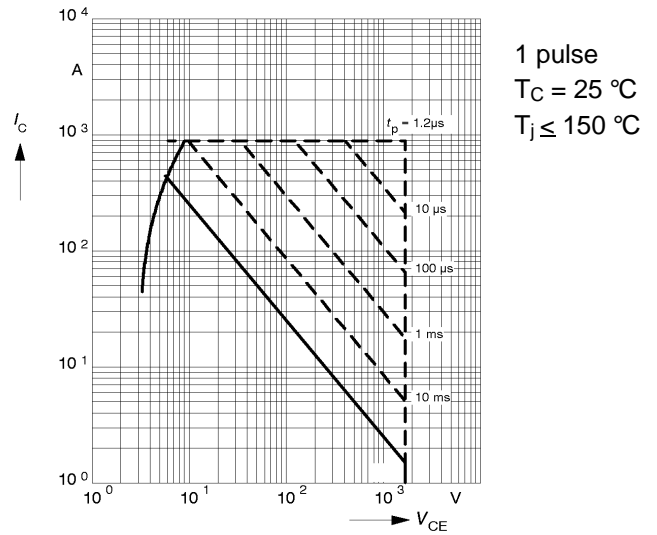


Fig. 4 Maximum safe operating area (SOA) $I_C = f(V_{CE})$

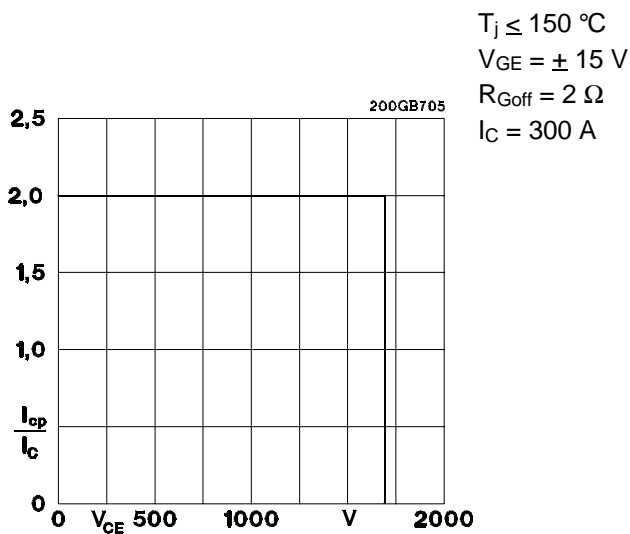


Fig. 5 Turn-off safe operating area (RBSOA)

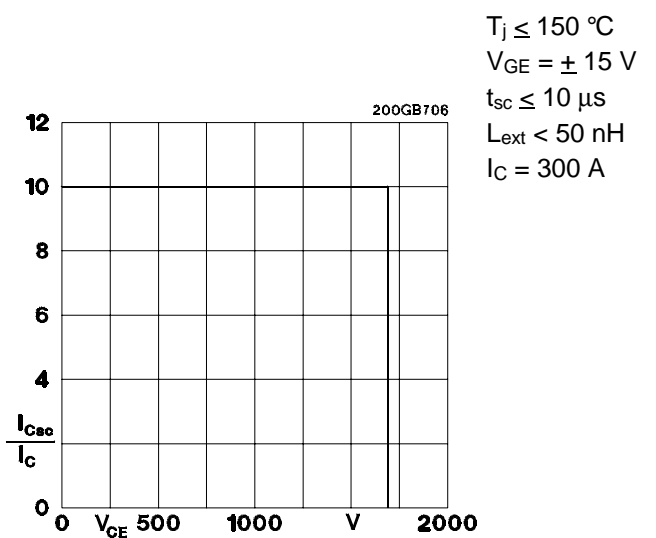


Fig. 6 Safe operating area at short circuit $I_C = f(V_{CE})$

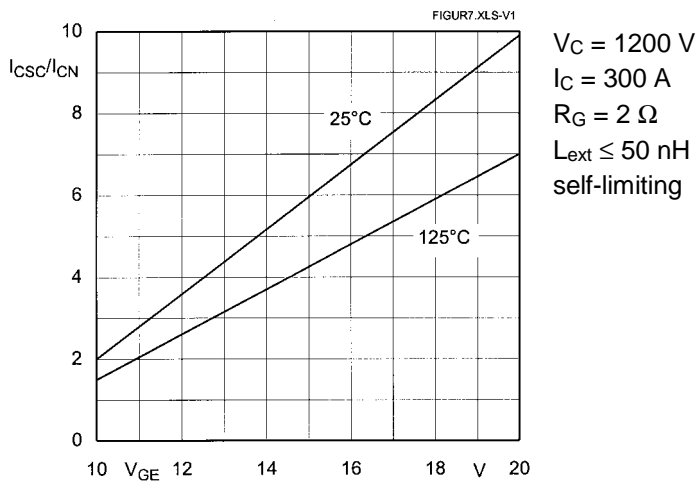


Fig. 7 Short circuit current vs. turn-on gate voltage

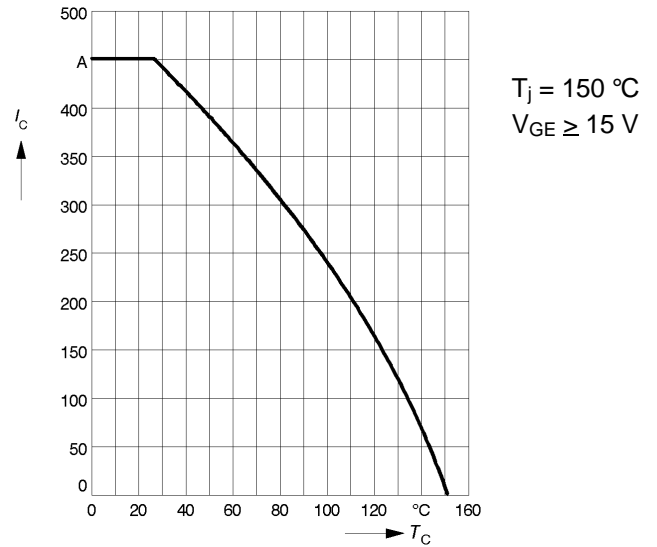


Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

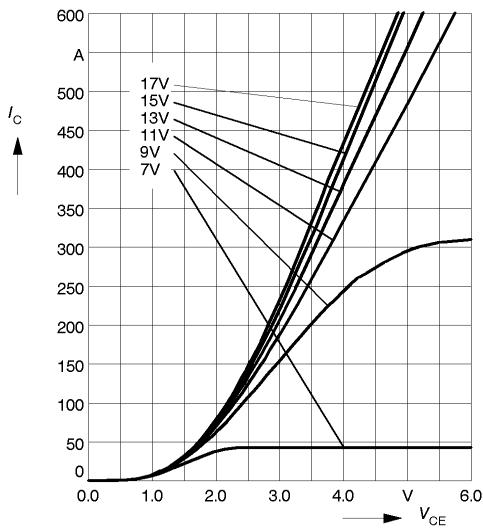


Fig. 9 Typ. output characteristic, $t_p = 80 \mu\text{s}$; $T_j = 25 \text{ }^\circ\text{C}$

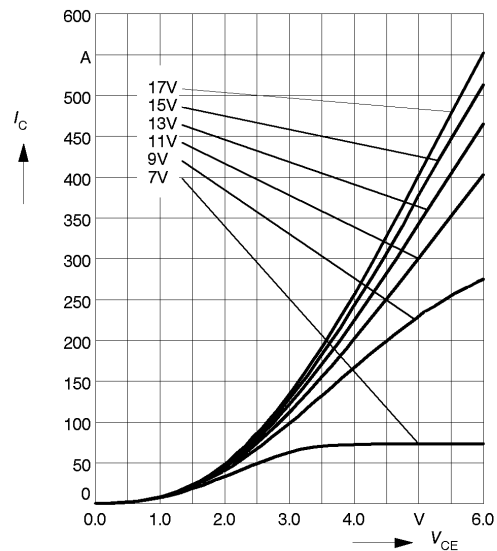


Fig. 10 Typ. output characteristic, $t_p = 80 \mu\text{s}$; $T_j = 125 \text{ }^\circ\text{C}$

$$P_{\text{cond}(t)} = V_{CE\text{sat}(t)} \cdot I_C(t)$$

$$V_{CE\text{sat}(t)} = V_{CE(TO)(T_j)} + r_{CE(T_j)} \cdot I_C(t)$$

$$V_{CE(TO)(T_j)} \leq 1,9 + 0,003 (T_j - 25) \text{ [V]}$$

$$r_{CE(T_j)} = 0,006 + 0,00002 (T_j - 25) \text{ [\Omega]}$$

$$\text{valid for } V_{GE} = +15 \frac{+2}{-1} \text{ [V]; } I_C \geq 0,3 I_{C\text{nom}}$$

Fig. 11 Typ. saturation characteristic (IGBT)
 Calculation elements and equations

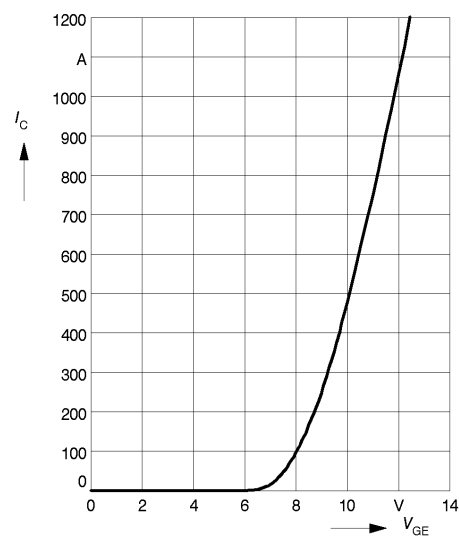


Fig. 12 Typ. transfer characteristic, $t_p = 80 \mu\text{s}$; $V_{CE} = 20 \text{ V}$

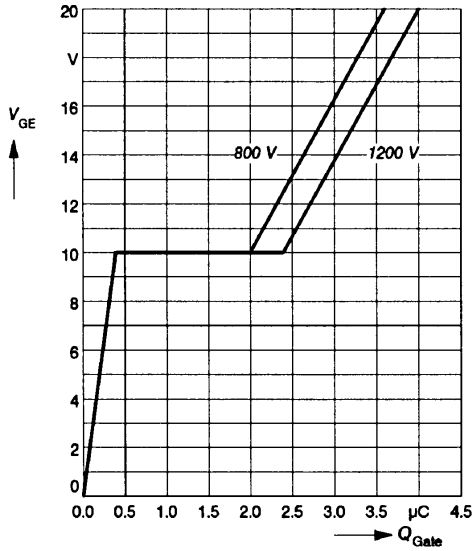


Fig. 13 Typ. gate charge characteristic

$I_{Cpuls} = 300 \text{ A}$

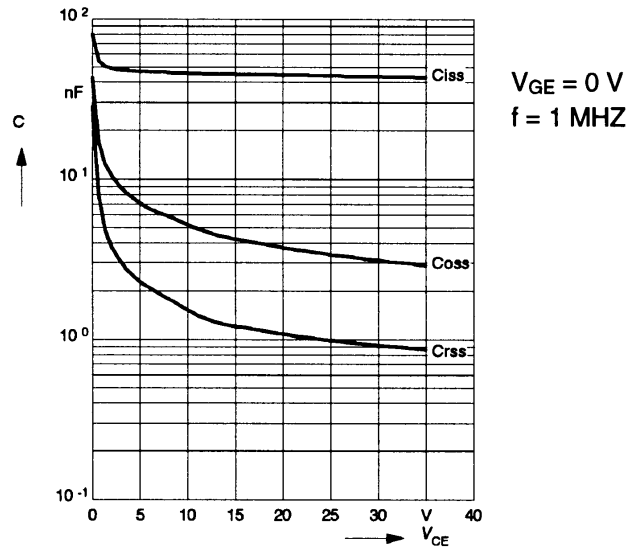


Fig. 14 Typ. capacitances vs. V_{CE}

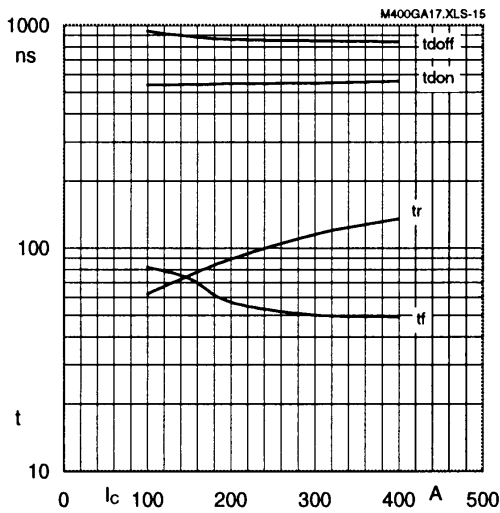


Fig. 15 Typ. switching times vs. I_C

$T_j = 125 \text{ }^\circ\text{C}$
 $V_{CC} = 1200 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_g = 2 \text{ } \Omega$

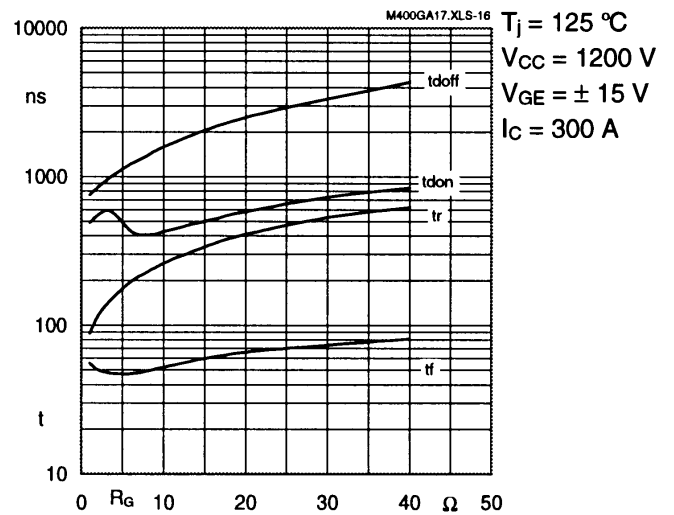


Fig. 16 Typ. switching times vs. R_G

$T_j = 125 \text{ }^\circ\text{C}$
 $V_{CC} = 1200 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_C = 300 \text{ A}$

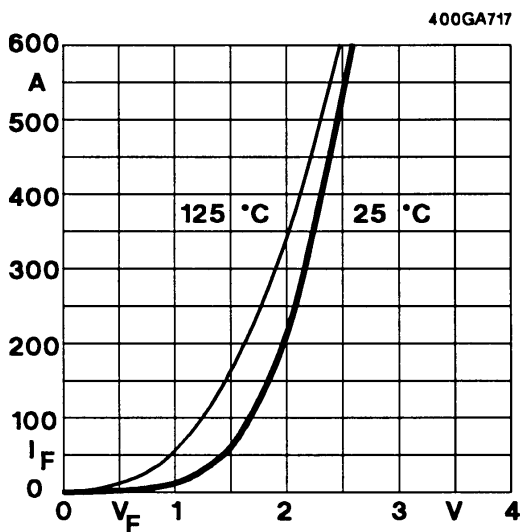


Fig. 17 Typ. CAL diode forward characteristic

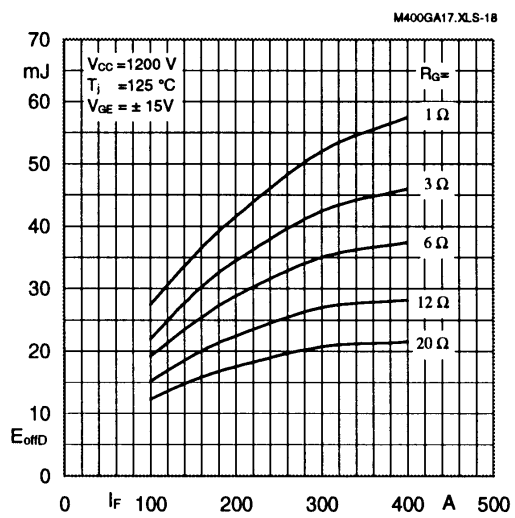


Fig. 18 Typ. Diode turn-off energy dissipation per pulse

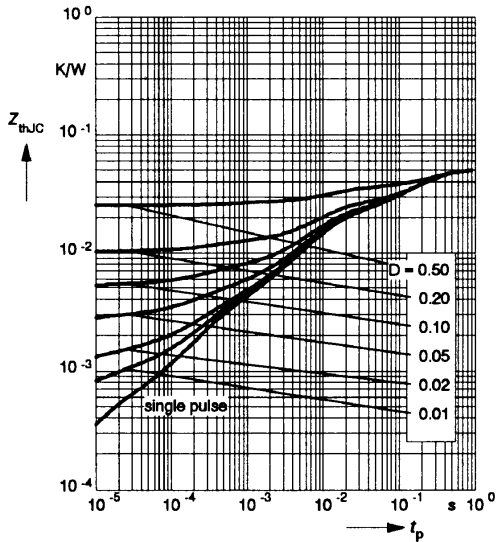


Fig. 19 Transient thermal impedance of IGBT: $Z_{thjC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

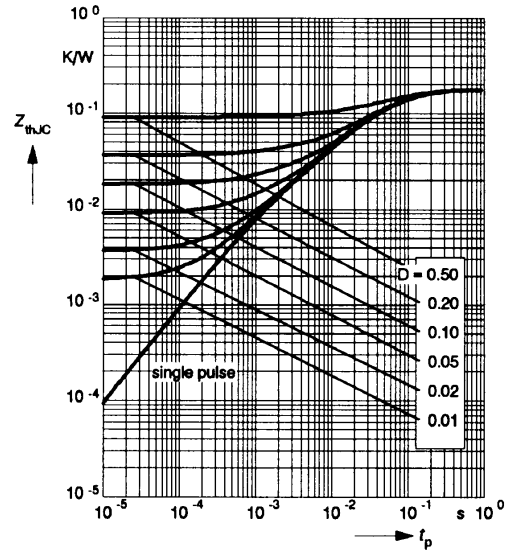


Fig. 20 Transient thermal impedance of inverse diode: $Z_{thjCD} = f(t_p)$

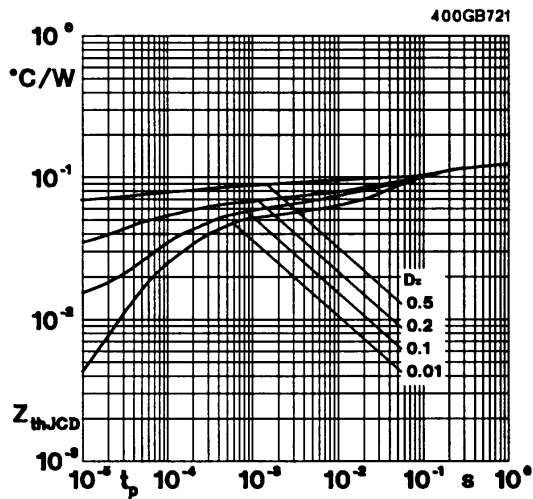


Fig. 21 Transient thermal impedance of Diode D1: $Z_{thjCD} = f(t_p)$

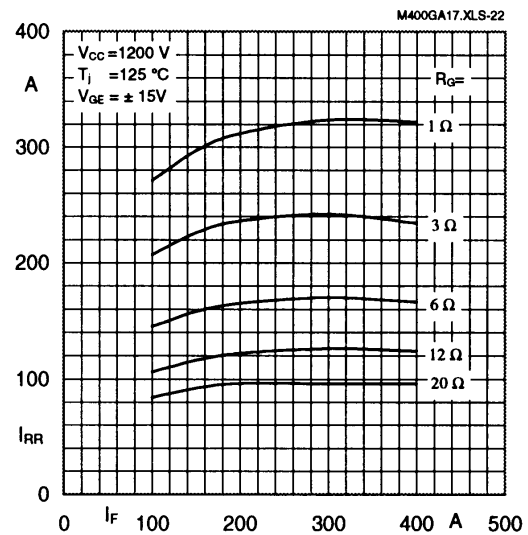


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

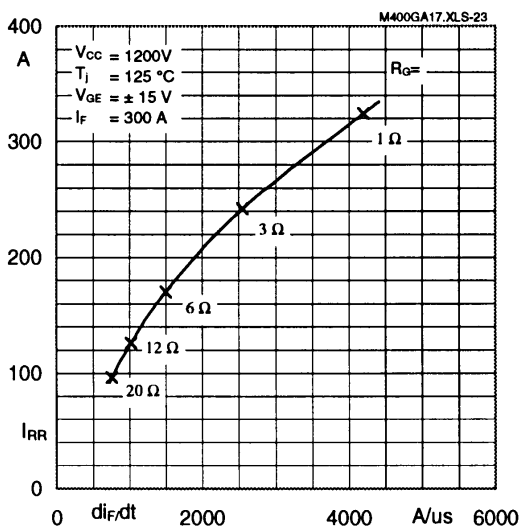


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di_F/dt)$

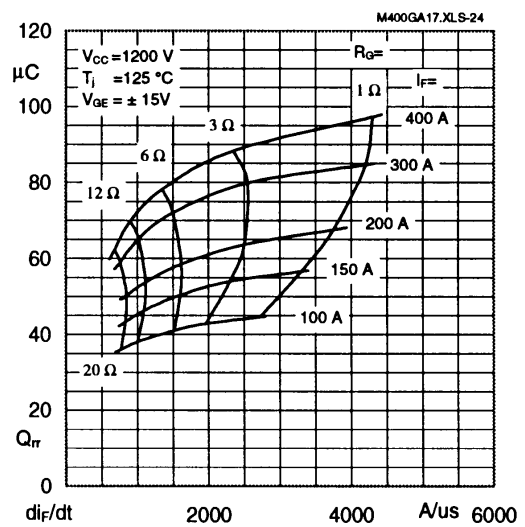


Fig. 24 Typ. CAL diode recovered charge Q_{rr}

SEMITRANS 4

Case D 59

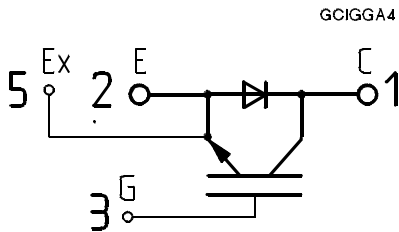
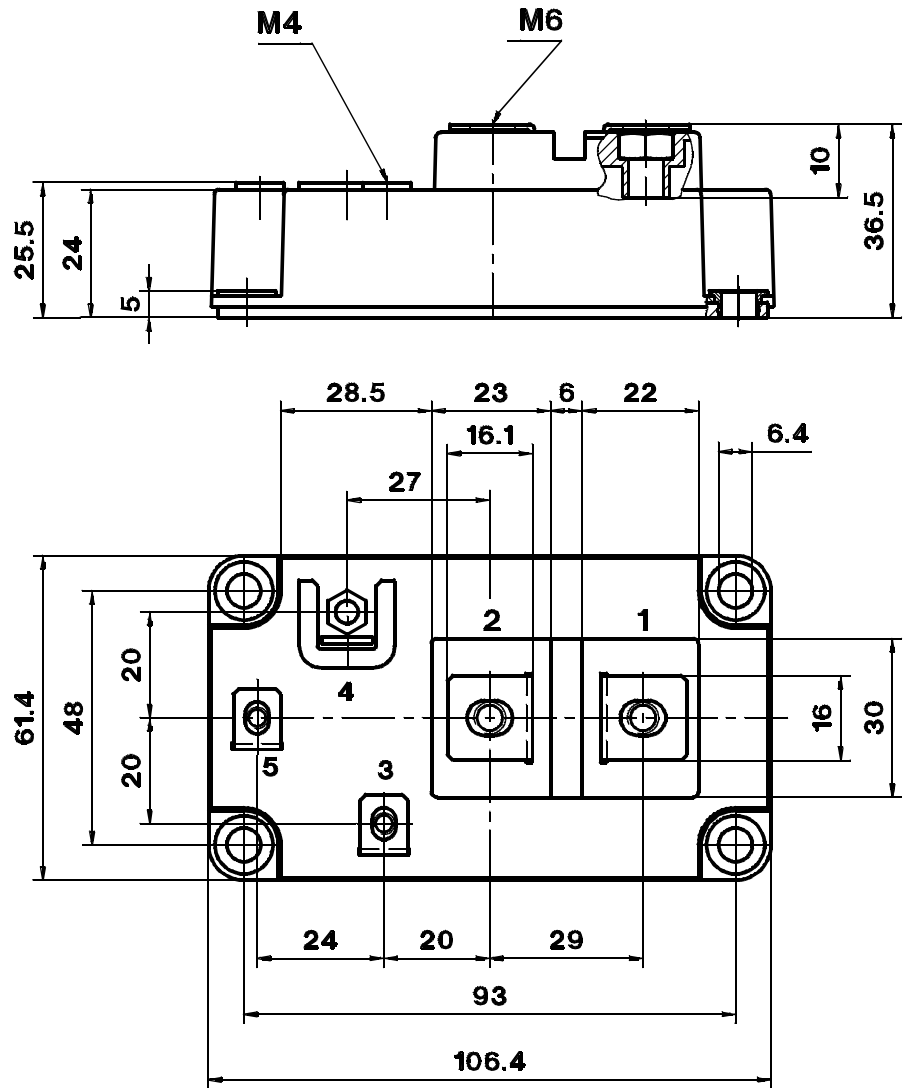
UL Recognized

File no. E 63 532

CASED59

SKM 400 GA 173 D

SKM 500 GA 123 D



Dimensions in mm

Option SKM 400 GA 173 D1S on request:
Terminal 4 = collector sense V_{CE} , add suffix "S". → B 6 – 212.

Outline and circuit

Mechanical Data		Values			Units
Symbol	Conditions	min.	typ.	max.	
M ₁	to heatsink, SI Units to heatsink, US Units	(M6) 3 27	–	5 44	Nm lb.in.
M ₂	for terminals, SI Units for terminals US Units	(M6/M4) 2,5/1,1 22/10	–	5/2 44/18	Nm lb.in.
a		–	–	5x9,81	m/s ²
w		–	–	330	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Three devices are supplied in one SEMIBOX B without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 4). Larger packing units of 12 and 20 pieces are used if suitable
Accessories → B 6 - 4.
SEMIBOX B → C - 2.